

<b>Notice of References Cited</b>	Application/Control No. 10/708,622		Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Michael Vanchy Jr.		Art Unit 2609	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,703,363 A	10-1987	Kitamura, Hideaki	358/448
*	B	US-5,198,892 A	03-1993	Misawa, Takeshi	348/578
*	C	US-5,541,648 A	07-1996	Udagawa et al.	348/222.1
*	D	US-6,091,862 A	07-2000	Okisu, Noriyuki	382/300
*	E	US-6,130,960 A	10-2000	Acharya, Tinku	382/167
*	F	US-6,236,433 B1	05-2001	Acharya et al.	348/273
*	G	US-6,229,578 B1	05-2001	Acharya et al.	348/607
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.